# **UROP Notes**

#### MICHAEL DIAO

# 1 RCTD

Our ultimate goal is to determine the fractional contributions of each cell type to a particular sample. We do this by maximum likelihood, using the following hierarchical model:

$$Y_{i,j} \mid \lambda_{i,j} \sim \text{Poisson}(N_i \lambda_{i,j})$$
  
 $\log \lambda_{i,j} = \log(\vec{\beta}_i \cdot \vec{\mu}_j) + \alpha_i + \gamma_j + \varepsilon_{i,j},$ 

where

- $Y_{i,j}$  is the random variable corresponding to the observed expression of gene j at pixel i,
- $N_i$  is the number of transcripts for pixel i,
- $\vec{\beta}_i$  is the *K*-dimensional row vector of contributions from each cell type (where *K* is the number of cell types in question) at pixel *i*,
- $\vec{\mu}_j$  is the *K*-dimensional column vector of mean expressions of gene *j* for each cell type,
- $\alpha_i$  is a fixed pixel-specific effect.
- $\gamma_j$  and  $\varepsilon_{i,j}$  are random effects that introduce noise.  $\gamma_j$  in particular is intended to account for platform effects that may over- or underrepresent certain genes. We let these be normally distributed with mean 0 and variance  $\sigma_{\gamma}$ ,  $\sigma_{\varepsilon}$  respectively.

Therefore, determining the fractional contributions of each cell type reduces to finding the maximum likelihood parameter  $\vec{\beta}_i$  for each i.

**Question 1.1.** Now we have a ton of parameters, potentially thousands.  $\beta$  alone introduces  $K \times J$  of them. How do we do any useful estimation here?

We proceed in the following steps:

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## 1. Supervised estimation of cell type profiles.

Using a reference dataset, we estimate the parameters  $\mu_j$  of expression levels for gene j, giving  $\hat{\mu}_j$  which will be used in the next steps.

We can do this by obtaining a (e.g. scRNA-seq) reference annotated with cell types, after which  $\vec{\mu}_j$  can be estimated as the empirical average normalized expression of gene j within each cell type.

## 2. Gene filtering.

Using the estimated expression profiles  $\hat{\vec{\mu}}_j$ , we filter out genes that are not highly variable across cell types.

We can do this by taking the expression profiles  $\hat{\mu}_j$  and selecting genes with a minimum average expression and sufficiently high variance.

### 3. Platform Effect Normalization.

With an estimate for  $\vec{\mu}_j$ , it turns out we now have a way to estimate the platform effects  $\gamma_j$  as well. The idea is that we can consider the average observed expression across pixels

$$\mathsf{M}_j = \frac{1}{I} \sum_{i=1}^{I} \mathsf{Y}_{i,j},$$

whence

$$\log \mathbb{E}_{\mathsf{M}_{j}|\vec{\lambda}_{j}}[M_{j} \mid \lambda_{1,j}, \dots, \lambda_{I,j}] = \log \left(\frac{1}{I} \sum_{i=1}^{I} N_{i} \lambda_{i,j}\right)$$

$$= \log \left(\frac{1}{I} \sum_{i=1}^{I} N_{i} \exp \left(\log(\vec{\beta}_{i} \cdot \vec{\mu}_{j}) + \alpha_{i} + \gamma_{j} + \varepsilon_{i,j}\right)\right)$$

$$= \gamma_{j} + \log \left(\frac{1}{I} \sum_{i=1}^{I} N_{i}(\vec{\beta}_{i} \cdot \vec{\mu}_{j}) \exp \left(\alpha_{i} + \varepsilon_{i,j}\right)\right)$$

$$= \gamma_{j} + \log \left(\frac{1}{I} \sum_{i=1}^{I} \left(\sum_{k=1}^{K} \beta_{i,k} \cdot \mu_{k,j}\right) N_{i} \exp \left(\alpha_{i} + \varepsilon_{i,j}\right)\right)$$

$$= \gamma_{j} + \log \left(\sum_{k=1}^{K} \mu_{k,j} \sum_{i=1}^{I} \frac{N_{i}}{I} \beta_{i,k} \exp \left(\alpha_{i} + \varepsilon_{i,j}\right)\right)$$

$$= \gamma_{j} + \log \left(\overline{N} \sum_{k=1}^{K} \mu_{k,j} \left(\frac{1}{I} \sum_{i=1}^{I} \frac{N_{i}}{\overline{N}} \beta_{i,k} \exp \left(\alpha_{i} + \varepsilon_{i,j}\right)\right)\right)$$

$$= \gamma_{j} + \log \left(\overline{N} \sum_{k=1}^{K} \mu_{k,j} \beta_{k,j}\right),$$

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where

$$\overline{N} \stackrel{\text{def}}{=} \frac{1}{I} \sum_{i=1}^{I} N_i$$
 and  $B_{k,j} \stackrel{\text{def}}{=} \frac{1}{I} \sum_{i=1}^{I} \frac{N_i}{\overline{N}} \beta_{i,k} \exp(\alpha_i + \varepsilon_{i,j}).$ 

 $B_{k,i}$  has some desirable properties. In particular, we have

$$\mathbb{E}_{\hat{p}_{\mathsf{B}_{k,j}}}[B_{k,j}] = \mathbb{E}_{\hat{p}_{\mathsf{N},\varepsilon_{j},\beta_{k},\alpha}}\left[\frac{N}{\mathbb{E}_{i}[N]}\beta_{k}\exp(\alpha + \varepsilon_{j})\right]$$

$$= \mathbb{E}_{\hat{p}_{\varepsilon_{j},\beta_{k},\alpha}}[\beta_{k}\exp(\alpha + \varepsilon_{j})]$$

$$= \overline{\beta}_{k}\mathbb{E}_{\hat{p}_{\varepsilon_{j},\alpha}}[\exp(\alpha + \varepsilon_{j})]$$

$$\stackrel{\text{def}}{=} \overline{\beta}_{k}\beta_{0},$$

and as  $I \to \infty$ ,  $\text{Var}[B_{k,j}] \to 0$  (by Chebyshev's Inequality). Therefore, as  $I \to \infty$  we get  $B_{k,j} \approx \overline{\beta}_k \beta_0$  so

$$\log \mathbb{E}_{\mathsf{M}_j \mid \vec{\lambda}_j} \big[ M_j \mid \lambda_{1,j}, \dots, \lambda_{I,j} \big] \approx \gamma_j + \log \beta_0 + \log \bigg( \overline{N} \sum_{k=1}^K \mu_{k,j} \overline{\beta}_k \bigg).$$

Now we can estimate the platform effects  $\gamma_j$ . Let  $W_k \stackrel{\text{def}}{=} \overline{\beta}_k \beta_0$ . The idea is that we can approximate a model for M by

$$\mathsf{M}_{j} \mid \gamma_{j} \sim \mathrm{Poisson} \left( I \overline{N} e^{\gamma_{j}} \sum_{k=1}^{K} \mu_{k,j} W_{k} \right)$$

$$\gamma_{j} \sim \mathcal{N}(0, \sigma_{\gamma}^{2}).$$

We can then find the MLE estimates of W and  $\sigma_{\gamma}$  according to this model and hence obtain  $\hat{\gamma}$ . This is okay because conditioning on  $W_k$ , the distribution of  $\gamma_j$  behaves like a delta function so we can approximate  $\gamma_j$  by the MLE of  $\gamma$ .

# 4. Robust Cell Type Decomposition.

With  $\hat{\mu}_{k,j}$  and  $\hat{\gamma}_j$  determined, we then find the MLE estimate for  $\alpha_i$ ,  $\vec{\beta}_i$  and  $\sigma_{\varepsilon}$  in our original model.

We are not yet done after estimating each  $\hat{\beta}_{i,k}$ . We want to incorporate our prior information that each pixel i is a mixture of a small number of cell types. Hence, we consider models that only consider one or two cell types, and favor "singlet" models  $\mathcal{M}$  by minimizing the Akaike Information Criterion

$$AIC(\mathcal{M}) = \mathcal{L}(\mathcal{M}) + V \cdot p(\mathcal{M}),$$

where  $\mathcal{L}$  is the log likelihood, V is a penalty parameter and  $p(\cdot)$  is the number of parameters of the model.